Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/394,824	CHIN ET AL.		
Examiner	Art Unit		
Phu K Nauven	2628		

SEARCHED				
Class	Subclass	Date	Examiner	
345	418-421	12/2/2005	cv	
	427	12/2/2005	CV	
update	search	6/26/2006	PN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST search SEE ATTACHED	11/28/2005	CV
WEST search - rotation, viewpoint, display - SEE ATTACHED	6/26/2006	PN
Nonpatent literature (IEEE, ACM) search - rotation, viewpoint, display - SEE ATTACHED	6/26/2006	PN
Inventor Name search	6/26/2006	PN